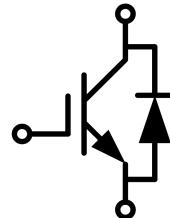


IGBT Discrete with Anti-Parallel Diode

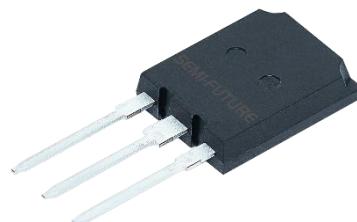
电气特性/ Features and Benefits:

- 1200V 沟槽栅/场终止工艺
1200V trench gate/field termination process
- 低开关损耗
Low switching losses
- V_{cesat} 正温度系数
V_{cesat} has a positive temperature coefficient



典型应用/ Applications:

- 不间断电源
Uninterruptible power supplies
- 光伏逆变器
Solar inverters



V_{CES} = 1200V, I_{C nom} = 120A / I_{CRM} = 360A

关键性能和程序参数 / Key Performance and Package Parameters

Type	V _{CE}	I _C	V _{CESat} , T _{vj} =25°C	T _{vjmax}	Package
SD120R12I7H	1200V	120A	1.83V	175°C	TO-247PLUS-3L

双极晶体管/IGBT

最大额定值 / Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
集电极-发射极电压 Collector-Emitter voltage	T _{vj} =25°C	V _{CES}	1200	V
连续集电极直流电流 Continuous DC collector current	T _C =100°C, T _{vj max} =175°C	I _{C nom}	120	A
集电极重复峰值电流 Repetitive peak collector current	t _p =1 ms	I _{CRM}	360	A
栅极-发射极电压 Gate emitter voltage	t _p ≤ 0.5μs, D<0.001	V _{GE}	±20 ±25	V
总功率损耗 Power dissipation	T _C =25°C T _C =100°C	P _{tot}	1010 505	W
在开关状态下温度 Temperature under switching conditions		T _{vj op}	-40...+175	°C

储存温度 Storage temperature		T _{stg}	-40...+150	°C
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热特性 / Thermal Characteristics

Parameter	Conditions	Symbol	Value	Unit
IGBT 热阻, 结-壳 IGBT thermal resistance, junction - case		R _{th(j-C)}	0.12	K/W
二极管热阻, 结-壳 Diode thermal resistance, junction - case		R _{th(j-C)}	0.22	K/W

特征值 / Characteristic Values

Parameter	Conditions	Symbol	Value			Unit	
			Min.	Typ.	Max.		
集电极-发射极饱和电压 Collector-Emitter saturation voltage	V _{GE} =15V, I _c =120A	V _{CEsat}	T _{vj} =25°C T _{vj} =150°C T _{vj} =175°C	1.83	2.2	V	
	V _{GE} =15V, I _c =120A			2.42			
	V _{GE} =15V, I _c =120A			2.53			
栅极-发射极阈值电压 Gate-Emitter threshold voltage	I _c =2.34mA, V _{GE} = V _{CE}	V _{GE(th)}	T _{vj} =25°C	5.0	5.6	6.2	V
跨导 Transconductance	V _{CE} =20V, I _c =120A	G _{fs}		95			S
输入电容 Input capacitance	f=100kHz, V _{CE} =25 V, V _{GE} =0 V	C _{ies}	T _{vj} =25°C	17.07			nF
输出电容 Output capacitance				0.40			nF
反向传输电容 Reverse transfer capacitance				0.13			nF
门极电荷 Gate charge	I _c = 120 A, V _{GE} = 15 V, V _{CE} = 960 V	Q _G	T _{vj} =25°C		1.06		μC
集电极-发射极截止电流 Collector-emitter cut-off current	V _{CE} =1200V , V _{GE} = 0 V	I _{CES}	T _{vj} =25°C		40		μA
栅极-发射极漏电流 Gate-emitter leakage current	V _{CE} =0 V, V _{GE} = 20 V	I _{GES}	T _{vj} =25°C		100		nA
开通延迟时间 Turn-on delay time	I _c =120A, V _{CE} =600V V _{GE} =±15 V, R _G =3.3Ω (电感负载) / (inductive load)	t _{d(on)}	T _{vj} =25°C T _{vj} =175°C		29	ns	
					30		
上升时间 Rise time	I _c =120A, V _{CE} =600V V _{GE} =±15 V, R _G =3.3Ω (电感负载) / (inductive load)	t _r	T _{vj} =25°C T _{vj} =175°C		197	ns	
					164		
关断延迟时间 Turn-off delay time	I _c =120A, V _{CE} =600V V _{GE} =±15 V, R _G =3.3Ω (电感负载) / (inductive load)	t _{d(off)}	T _{vj} =25°C T _{vj} =175°C		152	ns	
					185		
下降时间 Fall time	I _c =120A, V _{CE} =600V V _{GE} =±15 V, R _G =3.3Ω (电感负载) / (inductive load)	t _f	T _{vj} =25°C T _{vj} =175°C		70	ns	
					136		

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开通损耗能量 (每脉冲) Turn-on energy loss per pulse	I _C =120A, V _{CE} =600V V _{GE} =±15 V, R _G =3.3Ω di/dt=600A/us(T _{vj} =175°C) (电感负载) / (inductive load)	T _{vj} =25°C T _{vj} =175°C	E _{on}	17.49 26.06		mJ
关断损耗能量 (每脉冲) Turn-off energy loss per pulse	I _C =120A, V _{CE} =600V V _{GE} =±15 V, R _G =3.3Ω dv/dt=8400V/us(T _{vj} =175°C) (电感负载) / (inductive load)	T _{vj} =25°C T _{vj} =175°C	E _{off}	4.11 6.55		mJ

二极管/Diode

最大额定值 / Maximum Ratings

Parameter	Conditions	Symbol	Value		Unit
反向重复峰值电压 Repetitive peak reverse voltage	T _{vj} =25°C	V _{RRM}	1200		V
连续正向直流电流 Continuous DC forward current	T _C =100°C, T _{vj max} =175°C	I _F	60		A
正向重复峰值电流 Repetitive peak forward current	t _p =1ms	I _{FRM}	180		A

特征值 / Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
正向电压 Forward voltage	I _F =60A, V _{GE} =0V	V _F	1.74	2.20	V	
	I _F =60A, V _{GE} =0V					
	I _F =60A, V _{GE} =0V					
反向恢复峰值电流 Peak reverse recovery current	I _F =60A, -di _F /dt=650A/μs(T _{vj} =175°C)	I _{RM}	46	70	A	
	V _R =600V, V _{GE} =-15V					
	T _{vj} =25°C T _{vj} =175°C					
反向恢复电荷 Reverse Recovered charge	I _F =60A, -di _F /dt=650A/μs(T _{vj} =175°C)	Q _{rr}	5.75	20.35	μC	
	V _R =600V, V _{GE} =-15V					
	T _{vj} =25°C T _{vj} =175°C					
反向恢复时间 Reverse Recovery Time	I _F =60A, -di _F /dt=650A/μs(T _{vj} =175°C)	t _{rr}	253	654	ns	
	V _R =600V, V _{GE} =-15V					
	T _{vj} =25°C T _{vj} =175°C					
反向恢复损耗 (每脉冲) Reverse recovered energy	I _F =60A, -di _F /dt=650A/μs(T _{vj} =175°C)	E _{rec}	2.13	7.55	mJ	
	V _R =600V, V _{GE} =-15V					
	T _{vj} =25°C T _{vj} =175°C					

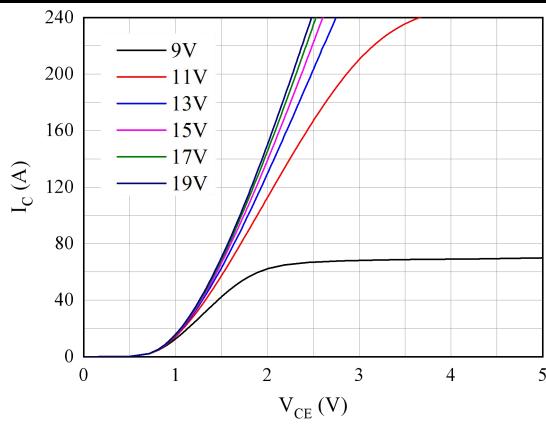
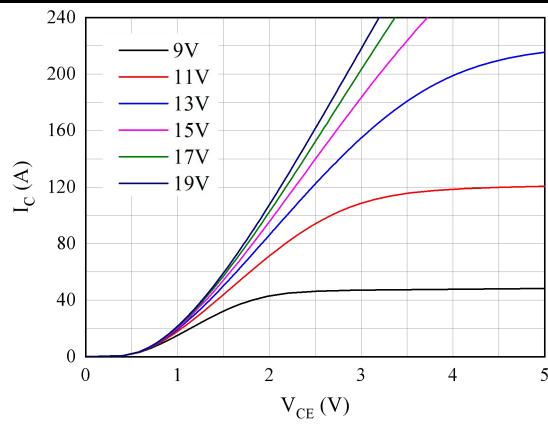
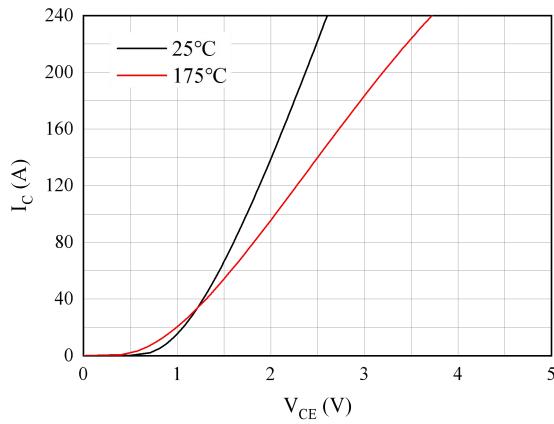
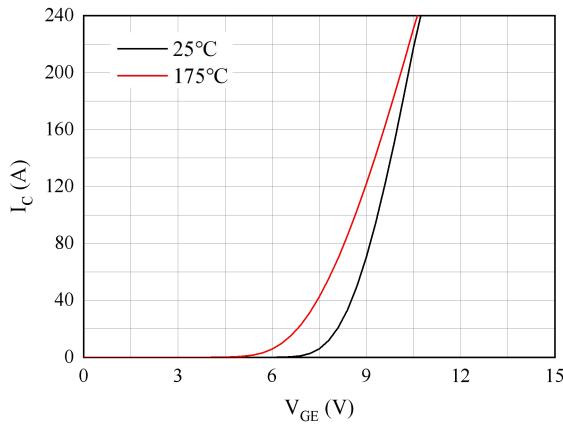
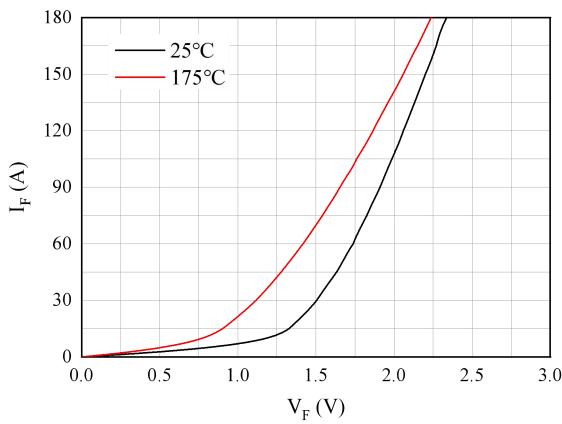
图 1. 典型输出特性 ($T_{vj}=25^{\circ}\text{C}$)Figure 1. Typical output characteristics ($T_{vj}=25^{\circ}\text{C}$)图 2. 典型输出特性 ($T_{vj}=175^{\circ}\text{C}$)Figure 2. Typical output characteristics ($T_{vj}=175^{\circ}\text{C}$)图 3. 典型输出特性 ($V_{GE}=15\text{V}$)Figure 3. Typical output characteristics ($V_{GE}=15\text{V}$)图 4. 典型传输特性($V_{CE}=20\text{V}$)Figure 4. Typical transfer characteristic($V_{CE}=20\text{V}$)

图 5. 正向偏压特性二极管

Figure 5. Forward characteristic of Diode

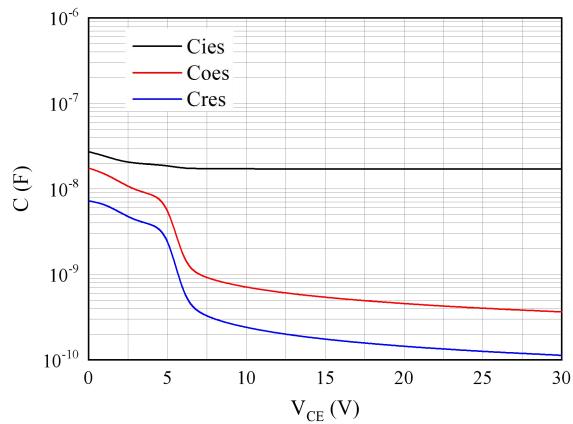


图 6. 电容特性

Figure 6. Capacitance characteristic

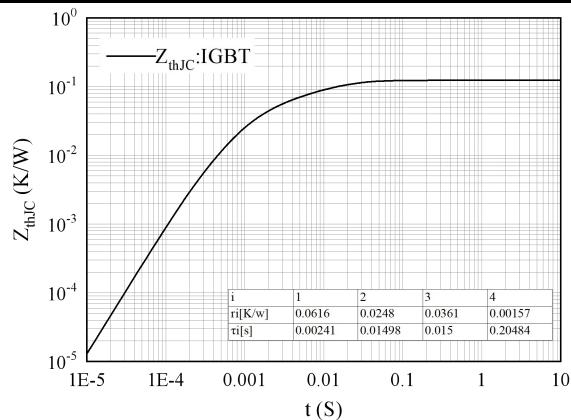


图 7. 瞬态热阻抗 IGBT

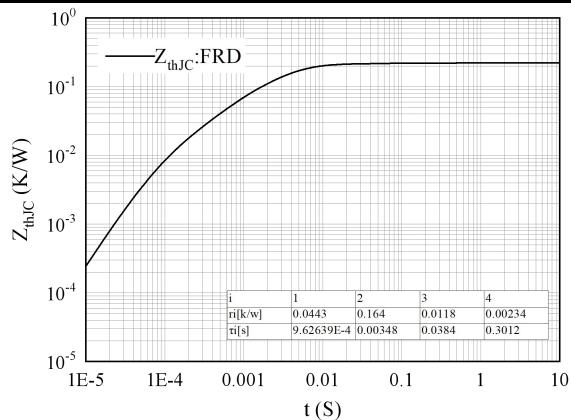
Figure 7. Transient thermal impedance IGBT,
 $Z_{thJC}=f(t)$ 

图 8. 瞬态热阻抗 FRD

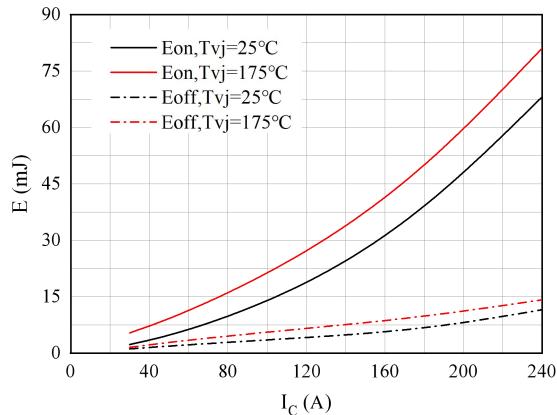
Figure 8. Transient thermal impedance FRD,
 $Z_{thJC}=f(t)$ 

图 9. 开关损耗

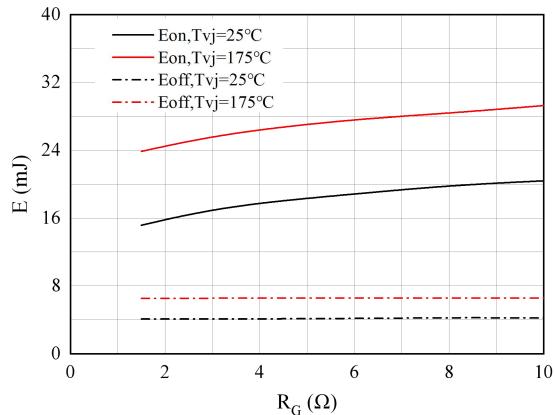
Figure 9. Switching losses of IGBT
 $V_{GE}=\pm 15V$, $R_{Gon}=3.3\Omega$, $R_{Goff}=3.3\Omega$, $V_{CE}=600V$ 

图 10. 开关损耗

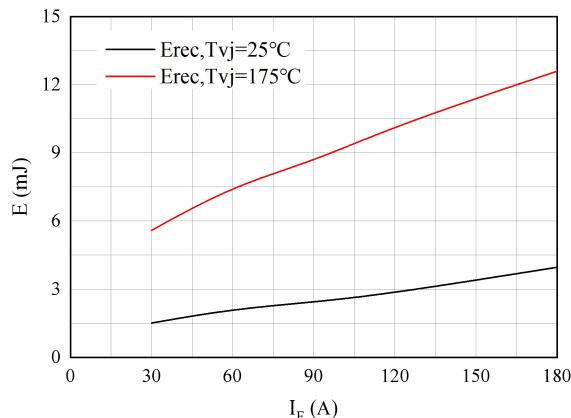
Figure 10. Switching losses of IGBT
 $V_{GE}=\pm 15V$, $I_C=120A$, $V_{CE}=600V$ 

图 11. 开关损耗 二极管

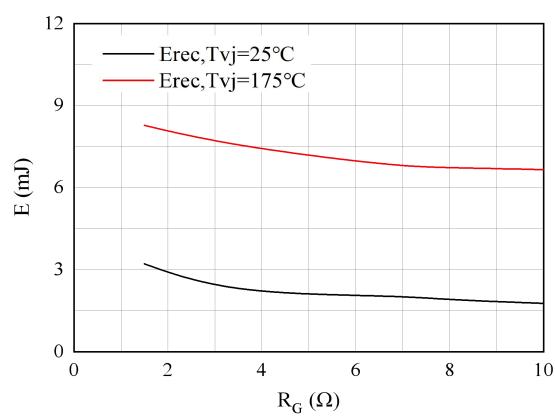
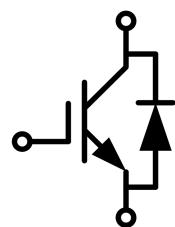
Figure 11. Switching losses of Diode
 $R_{gon}=3.3\Omega$, $V_{CE}=600V$ 

图 12. 开关损耗 二极管

Figure 12. Switching losses of Diode
 $I_F=60A$, $V_{CE}=600V$

接线图 / Circuit diagram



封装尺寸 / Package outlines

